## **Correction to Optically Abrupt Localized** Surface Plasmon Resonances in Si Nanowires by Mitigation of Carrier

Density Gradients [ACS Nano 2015, 9, 1250-1256. DOI: 10.1021/nn504974z]. Li-Wei Chou, Dmitriy S. Boyuk, and Michael A. Filler\*

Pages 1251 and 1254. We inadvertently omitted the length of the scale bar for the scanning electron microscope image insets in Figures 1a and Figure 6. The scale bar length is 100 nm in both figures. This does not modify the results, discussion, or conclusions of the paper.

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